# MOTOROLA SEMICONDUCTOR TECHNICAL DATA

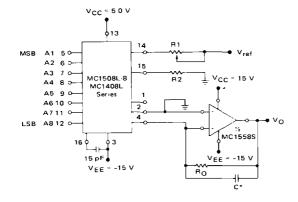
## MC1458S MC1558S

## DUAL HIGH SLEW RATE, INTERNALLY COMPENSATED OPERATIONAL AMPLIFIERS

The MC1558S is functionally equivalent, pin compatible, and possesses the same ease of use as the popular MC1558 circuit, yet offers 20 times higher slew rate and power bandwidth. This device is ideally suited for D/A converters due to its fast settling time and high slew rate.

- High Slew Rate 10 V/µs Guaranteed Minimum (for inverting unity gain only)
- No Frequency Compensation Required
- Short-Circuit Protection
- Offset Voltage Null Capability
- Wide Common-Mode and Differential Voltage Ranges
- Low Power Consumption
- No Latch-Up

## TYPICAL APPLICATION OUTPUT CURRENT TO VOLTAGE TRANSFORMATION FOR A D-TO-A CONVERTER



Settling time to within 1/2 LSB (±19.5 mV) is approximately 4.0 µs from the time that all bits are switched.

\*The value of C may be selected to minimize overshoot and ringing (C  $\approx$  68 pF).

Theoretical V<sub>O</sub>  

$$V_O = \frac{V_{ref}}{R1} (R_O)$$
  $\left[ \frac{A1}{2} + \frac{A2}{4} + \frac{A3}{8} + \frac{A4}{16} + \frac{A5}{32} + \frac{A6}{64} + \frac{A7}{128} + \frac{A8}{256} \right]$ 

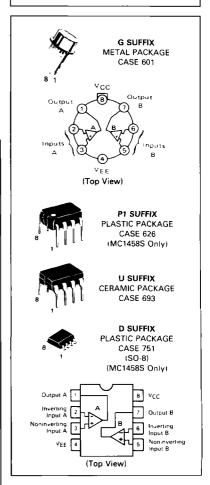
Adjust  $\rm V_{ref},\,R1$  or  $\rm R_O$  so that  $\rm V_O$  with all digital inputs at high level is equal to 9 961 volts.

$$V_{ref}$$
 = 2.0 Vdc  
R1 = R2  $\geq$  1.0 k $\Omega$   
R $_{O}$  = 5.0 k $\Omega$ 

$$v_{Q} = \frac{2 \ V}{1 \ k} \ \left( 5 \ k \right) \left[ \frac{1}{2} + \frac{1}{4} + \frac{1}{8} + \frac{1}{16} + \frac{1}{32} + \frac{1}{64} + \frac{1}{128} + \frac{1}{256} \right] = 10 \ V \left[ \frac{255}{256} \right] = 9.961 \ V$$

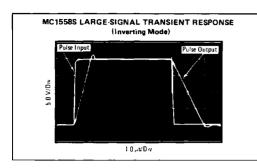
# DUAL OPERATIONAL AMPLIFIERS

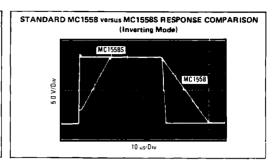
SILICON MONOLITHIC INTEGRATED CIRCUIT



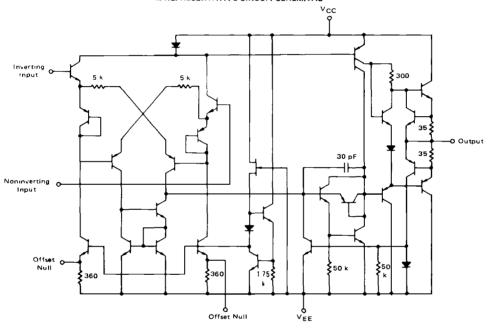
#### ORDERING INFORMATION

Device Temperature Range		Package
MC1458SD MC1458SG MC1458SP1 MC1458SU	0°C to +70°C	SO-8 Metal Can Plastic DIP Ceramic DIP
MC1558SG MC1558SU	- 55°C to + 125°C	Metal Can Ceramic DIP





#### 1/2 REPRESENTATIVE CIRCUIT SCHEMATIC



MAXIMUM RATINGS (TA = +25°C unless otherwise noted )

Rating	Symbol	MC1558S MC1458S		Unit	
Power Supply Voltage	V <sub>CC</sub> V <sub>EE</sub>	+22 -22	+18 -18	Vdc	
Input Differential Voltage Range (1)	VIDR	±3	Volts		
Input Common-Mode Voltage Range ②	VICR	±1	Volts		
Output Short Circuit Duration	ts _	Conti	nuous		
Operating Ambient Temperature Range	TA	-55 to +125	0 to +70	°c	
Storage Temperature Range	T <sub>stg</sub>	T <sub>stg</sub> -65 to +150 -65 to +150		°c	
Junction Temperature Ceramic and Metal Package Plastic Package	TJ	175 150	175 150	°c °c	

Note 1 For supply voltages less than ±15 Vdc, the absolute maximum input voltage is equal to the supply voltage.

Note 2. Supply voltage equal to or less than 15 Vdc.

## MC1458S, MC1558S

ELECTRICAL CHARACTERISTICS (V<sub>CC</sub> = +15 Vdc, V<sub>EE</sub> = -15 Vdc, T<sub>A</sub> = +25°C unless otherwise noted )

	Symbol	MC1558S			MC1458S			
Characteristic		Min Typ		Max	Min	Тур	Max	Unit
Power Bandwidth (See Figure 3)	8Wp							kHz
$A_v = 1$ , $R_L = 2.0 \text{ k}\Omega$ , THD = 5%, $V_O = 20 \text{ V(p+p)}$	'	150	200	-	150	200	_	· -
Large-Signal Transient Response								
Slew Rate (Figures 10 and 11)	SR							
V(-) to V(+)		10	20	-	10	20		عبر∨
V(+) to V(-)		10	12	-	10	12	-	
Settling Time (Figures 10 and 11)	t set lo	-	30	-	-	30	-	μs
(to within 0.1%)								'
Small-Signal Transient Response								
(Gain = 1, $E_{in}$ = 20 mV, see Figures 7 and 8)								
Rise Time	<sup>t</sup> TLH	-	0 25	-	-	0.25		μs
Fall Time	<sup>†</sup> THL	-	0 25	-	-	0 25	~	μs
Propagation Delay Time	tPLH.tPHL	-	0 25	-	-	0 25	-	μs
Overshoot	os	-	20	-	-	20		٥,0
Short-Circuit Output Currents	los	±10	-	±45	±10	-	± 45	mA
Open Loop Voltage Gain (R 2 0 ks) (See Figure 4)	AVOL							-
V <sub>O</sub> - ±10 V		50,000	200,000	-	20,000	100,000		
Output Impedance (f - 20 Hz)	ž <sub>O</sub>	-	75	-	-	75	-	Ω
Input Impedance (f = 20 Hz)	z <sub>1</sub>	0.3	10	-	0.3	10	-	MΩ
Output Voltage Swing	Vo							Vok
B <sub>L</sub> 10 kΩ		±12	±14	-	±12	±14		"
A		±10	±13		±10	±13		
Input Common Mode Voltage Swing	VICR	±12	±13	-	±12	±13	-	V <sub>pk</sub>
Common-Mode Rejection Ratio (f = 20 Hz)	CMAA	70	90		70	90		₫B
Input Bias Current (See Figure 2)	I <sub>IB</sub>							пA
		-	200	500	-	200	500	
Input Offset Current	liol							nΑ
	<u> </u>		30	200	-	30	200	
Input Offset Voltage (R <sub>S</sub> : ≤ 10 kΩ)	Vio							m۷
	<u> </u>	-	10	5 0	-	20	60	
DC Power Consumption (See Figure 9)	PC							mW
(Power Supply = ±15 V, VO = 0)	1	-	70	150	-	70	170	
Positive Voltage Supply Sensitivity	PSS+				T			μV/V
(VEE constant)		-	20	150	-	20	150	
Negative Voltage Supply Sensitivity	PSS-		J					<b>μ</b> ∨′∨
(VCC constant)	1	-	10	150	-	10	150	1

<sup>\*\*</sup>Plastic package offered in limited temperature range device only

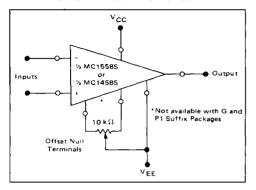
ELECTRICAL CHARACTERISTICS (V<sub>CC</sub> = +15 Vdc, V<sub>EE</sub> = -15 Vdc, T<sub>A</sub> = -55 to +125°C for MC1558S and T<sub>A</sub> = 0 to 70°C for MC1458S, unless otherwise noted.)

	Symbol	MC1558S			MC1458S			
Characteristic		Min	Тур	Max	Mın	Тур	Max	Unit
Open Loop Voltage Gain VO = ±10 V	Avol	25,000	-	-	15,000		-	V/V
Output Voltage Swing R <sub>L</sub> = 10 kΩ R <sub>L</sub> = 2 kΩ	v <sub>o</sub>	±12 ±10	-		±12 ±10	-	-	V <sub>pk</sub>
Input Common-Mode Voltage Range	VICE	:12	-	-	T -	_	-	Vpk
Commo i-Mode Rejection Ratio (f = 20 Hz)	CMRR	70	-	T -	-	-	-	dB
Input Bias Current $T_A = 125^{\circ}C$ $T_A = -55^{\circ}C$ $T_A = 0 \text{ to } 70^{\circ}C$	IIB	- - -	200 500	500 1500		- - -	- - 800	nA
Input Offset Current TA = 125 <sup>0</sup> C TA = -55 <sup>0</sup> C TA = 0 to 70 <sup>0</sup> C	IIO	- - -	30 - -	200 500	- - -	- - -	- - 300	nA
Input Offset Voltage RS ≤ 10 kΩ	v <sub>IO</sub>	-	-	60	-	<u> </u>	7 5	mV
DC Power Consumption VO = 0 V	PC	-	_	200	-	_	-	mW
Positive Power Supply Sensitivity VEE = -15 V	P <sub>SS+</sub>	-	-	150	-	_	-	μ∨/ν
Negative Power Supply Sensitivity VCC = 15 V	P <sub>SS</sub> -	-	-	150	=	T -	-	μV/V

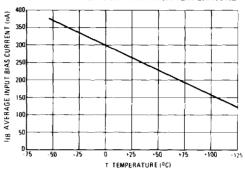
#### TYPICAL CHARACTERISTICS

(VCC = +15 Vdc, VEE = -15 Vdc, TA = +25°C unless otherwise noted.)

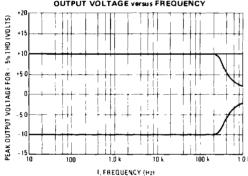
#### FIGURE 1 - OFFSET ADJUST CIRCUIT



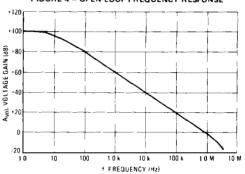
#### FIGURE 2 - INPUT BIAS CURRENT Versus TEMPERATURE



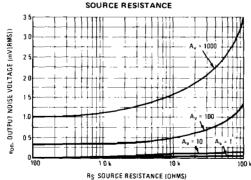




#### FIGURE 4 - OPEN-LOOP FREQUENCY RESPONSE



#### FIGURE 5 - OUTPUT NOISE versus



#### TYPICAL CHARACTERISTICS

(VCC = +15 Vdc, VEE = -15 Vdc, TA = +25°C unless otherwise noted.)

## FIGURE 6 - SMALL-SIGNAL TRANSIENT

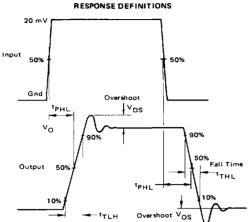


FIGURE 7 - SMALL-SIGNAL TRANSIENT RESPONSE

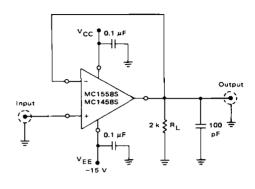
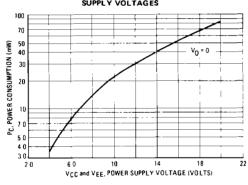


FIGURE 9 - LARGE-SIGNAL TRANSIENT WAVEFORMS

FIGURE 8 — POWER CONSUMPTION versus POWER SUPPLY VOLTAGES

Rise Time



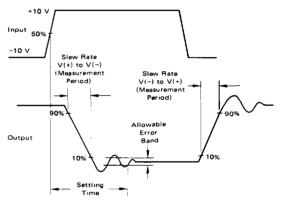
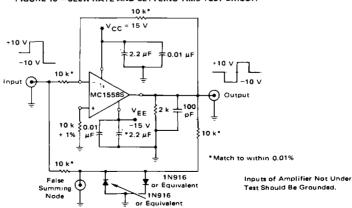


FIGURE 10 - SLEW RATE AND SETTLING TIME TEST CIRCUIT\*



#### SETTLING TIME

In order to properly utilize the high slew rate and fast settling time of an operational amplifier, a number of system considerations must be observed. Capacitance at the summing node and at the amplifier output must be minimal and circuit board layout should be consistent with common high-frequency considerations. Both power supply connections should be adequately bypassed as close as possible to the device pins. In bypassing, both low and high-frequency components should be considered to avoid the possibility of excessive ringing. In order to achieve optimum damping, the selection of a capacitor in parallel with the feedback resistor may be necessary. A value too small could result in excessive ringing while a value too large will degrade slew rate and settling time.

#### SETTLING TIME MEASUREMENT

In order to accurately measure the settling time of an operational amplifier, it is suggested that the "false" summing junction approach be taken as shown in Figure 11. This is necessary since it is difficult to determine when the waveform at the output of the operational amplifier settles to within 0.1% of it's final value. Because the output and input voltages are effectively subtracted from each other at the amplifier inverting input, this seems like an ideal node for the measurement. However, the probe capacitance at this critical node can greatly affect the accuracy of the actual measurement.

The solution to these problems is the creation of a second or "false" summing node. The addition of two diodes at this node clamps the error voltage to limit the voltage excursion to the oscilloscope. Because of the voltage divider effect, only one half of the actual error appears at this node. For extremely critical measurements, the capacitance of the diodes and the oscilloscope, and the settling time of the oscilloscope must be considered. The expression

$$t_{setla} = \sqrt{x^2 + y^2 + z^2}$$

can be used to determine the actual amplifier settling time, where

tsetlg = observed settling time

- x = amplifier settling time (to be determined)
- y = false summing junction settling time
- z = oscilloscope settling time

It should be remembered that to settle within  $\pm 0.1\%$  requires ZRC time constants.

The  $\pm 0.1\%$  factor was chosen for the MC1558S settling time as it is compatible with the  $\pm 1/2$  LSB accuracy of the MC1508L-8 digital-to-analog converter. This D-to-A converter features  $\pm 0.19\%$  maximum error.

#### TYPICAL APPLICATION

FIGURE 13 - 12 5-WATT WIDEBAND POWER AMPLIFIER

